## Applicant(s)/Patent Under Reexamination Application/Control No. 10/026,941 YER ET AL. Notic of References Cited Art Unit Examiner Page 1 of 1 Anh T. Mai 2832 **U.S. PATENT DOCUMENTS**

	Document Number Date					
*		Country Code-Number-Kind Code	MM-YYYY	Name	Classification	
	Α	US-4,352,081	09-1982	Kijima, Seiichi	336/198	
	В	US-6,326,874	12-2001	Banzi et al.	336/192	
	С	US-6,509,822	01-2003	Junjie et al.	336/198	
	D	US-3,668,586	06-1972	Horbach, Stephen	336/210	
	Ε	US-				
	F	US-				
	G	US-				
	Н	US-				
	1	US-				
	J	US-				
	К	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q	***				
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.